Interface Transparency of N b/P d Layered System s

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Abstract

We have investigated, in the fram ework of proximity e lect theory, the interface transparency T of superconducting/norm alm etal layered system s which consist of Nb and high param agnetic Pd deposited by dc m agnetron sputtering. The obtained T value is relatively high, as expected by theoretical arguments. This leads to a large value of the ratio $d_s^{cr} = s$ although Pd does not exhibit any m agnetic ordering. PACS: 74.45.+ c, 74.78 Fk

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I. IN TRODUCTION

Interface transparency T of arti cial layered system s is an interesting issue of study, both for its fundam ental and practical consequences and m any papers have been recently devoted to this topic [1{4]. From one side, in fact, T is related to di erences between Ferm ivelocities and band-structures of the two m etals. On the other hand it is an essential parameter to take into account in the study of depairing currents [5] and quasiparticle injection devices [6{9] where high interface transparency is an important ingredient.

In this article we perform ed a proximity e ect study of Nb/Pd layered system [10] taking into account the essential ingredient of interface transparency. We chose Nb as superconducting material and Pd as normal metal. The choice of Nb was related to its highest critical temperature among the superconducting elements while, among normal metals, Pd is the one with the larger spin susceptibility [11] which leads to giant magnetic moments in some dilute Pd alloys [12]. Moreover, by theoretical argument based on Ferm i velocities and band-structures mismatch, we expected a more transparent interface than in other superconductor/normal metal combinations, such as, for example, Nb/Cu [13].

II. THEORET ICAL BACKGROUND

W hen a superconductor (S) com es into contact with anotherm aterial (X) proximity e ect occurs. The other material can be a superconductor with a lower transition temperature (S'), a normal metal (N), a ferrom agnet (F) or a spin glass (M). In any case there is a mutual in uence which depresses superconductivity in S and induces superconductivity in X. Since at the interface the order parameter decreases in S over the coherence length $_{s}$, it is necessary a minimum thickness of the S layer, d_{s} , to make superconductivity appear. If d_{s} is small the order parameter cannot reach its maximum value and the critical temperature T_{c} of the system is reduced, until d_{s} becomes too thin and superconductivity is lost. The thickness at which it happens is called critical thickness, d_{s}^{cr} . On the other hand, C coper pairs coming from S penetrate X, but they are broken up over a characteristic length $_{x}$, depending on the pair breaking mechanism in X.At nite temperature pairs loose their phase coherence by thermal uctuations: this is the only pair breaking mechanism present in N metals, and lead to a temperature dependent characteristic distance, $_{n}$ (T), which can become large at low temperatures. In magnetic metals pair breaking is due to the exchange interaction E_{ex} which acts on the spin of the C ooper pairs. For strong magnets, such as Fe, $E_{ex} >> k_{\rm B}T$: this leads to a few Angstrom temperature independent coherence length $_{\rm F}$ in the magnetic layer [1,14,15].

Anyway interfaces between di erent m etals are never fully transparent with the result that proximity e ect is somehow screened, because electrons coming from S are rejected rather than transmitted in X.A nite transparency gives rise, for example, to a smaller d_s^{cr} . This may be due to interface imperfections, lattice m ismatches, fabrication m ethod [4,16], but also to intrinsic e ects such as di erence between Ferm i velocities and band-structures of the two m etals [13]. The interface transparency due to Ferm i velocities m ismatches in the free electron m odel, is given by [1,19]:

$$T = \frac{4k_x k_s}{[k_x + k_s]^2}$$
(1)

where $k_{x,s} = m v_{x,s} = h$ are the projections of Ferm i wave vectors of X and S m etals on the direction perpendicular to the interface. M oreover for the magnetic case the situation is more complicated due to the role played by the splitting of the spin subbands and the spin-dependent in purity scattering [17].

The starting point for a complete description of proximity e ect in multilayers, valid for arbitrary transparency, was given by K upriyanov and Lukichev [18] in the fram ework of U sadel equations (dirty limit). In particular, the model we used to describe the dependence T_c (d_s) for N/S/N trilayers is based on the W ertham er approximation, valid for not too low tem peratures, provided the boundary transparency is su ciently small [19]. In this limit the system of algebraic equations to determ ine T_c is:

$${}_{1} \tan \frac{1}{2} \frac{d_{s}}{s} = -\frac{1}{b}$$
(2)

$$\frac{1}{2} + \frac{\frac{2}{1}T_{cs}}{2T_{c}} + \frac{1}{2} = \ln \frac{T_{cs}}{T_{c}}; \frac{T_{cs}}{T_{c}} - \frac{1}{b}$$
(3)

with the identication of the Abrikosov-Gorkov pair-breaking parameter = $T_c \frac{2}{1} = T_c (= b) (2 s=d_s)$ where (x) is the digamma function and T_{cs} is the bulk critical tem – perature of the S layer. These equations contain two parameters and b de ned as

$$= \frac{s s}{n n}; b = \frac{R_B}{n n}$$
(4)

where $_{s}$ and $_{n}$ are the low temperature resistivities of S and N, respectively, while R_{B} is the normal-state boundary resistivity times its area. The parameter is a measure of the strength of the proximity e ect between the S and N metals and can be determined experimentally by measuring $_{s}$ Nb, $_{n}$ Pd, $_{s}$ Nb and $_{n}$ Pd. The parameter $_{b}$, instead, describes the e ect of the boundary transparency T, to which it is roughly related by

$$T = \frac{1}{1 + b}$$
(5)

Due to its dependence on R_B , which is dicult to measure, $_b$ (or T) can't be determined experimentally, so it was extracted by a tting procedure.

III.EXPER IM EN TAL RESULTS

The sam ples were grown on Si(100) substrates by a dual-source magnetically enhanced dc triode sputtering system and they consist of N b layers ($T_c = 8.8$ K) and Pd layers. The deposition conditions were sim ilar to those of the N b/Pd multilayers earlier described [10] except for the fact that the 8 sam ples, obtained in a single deposition run, were not heated. Three di erent sets of multilayers were prepared. Two sets (set A and set B), built as follows, $d_{Pd}=d_{Nb}=d_{Pd}$, were used to determ ine $d_s^{cr} = d_{Nb}^{r}$ by the variation of T_c as function of the N b layer thickness. Here d_{Pd} was xed at around 1500 A in order to represent a half-in nite layer, while d_{Nb} was variable from 200 to 1300 A. The third set (set C) was used to estimate $_{Pd}$ by the variation of T_c with d_{Pd} . Now the sam ples were made up of

ve layers: $d_{Pd}^{out}/d_{Nb}/d_{Pd}^{in}/d_{Nb}/d_{Pd}^{out}$, with the outer Pd layers of 300 A in order to create a sym metric situation for the Nb layers, with d_{Nb} xed at 500 A, while d_{Pd}^{in} was varied from 50 to 300 A. Extensive low and high angle X-ray diraction patterns has been performed to structurally characterize the sam ples. High angle scans clearly showed the Nb (110) and the Pd (111) preferred orientations and allow us to estimate the lattice parameters, $a_{Nb} = 3:3$ A for the bcc-Nb and $a_{Pd} = 3:9$ A for the fcc-Pd, in agreement with the values reported in literature [20]. Low angle re ectivity measurements on samples deliberately fabricated to perform structural characterization, show a typical interfacial roughness of 12 A [10].

The superconducting properties, transition temperatures T_c , perpendicular and upper critical magnetic elds H _{c2?} (T) and H _{c2k} (T) were resistively measured using a standard dc four-probe technique. The values obtained for the resistivities are independent of the layering and in the range 3-4 cm at 10 K. The ratios $_N$ (T = 300 K)/ $_N$ (T = 10 K), with $_N$ the norm all state resistivity, were in the range 1.7-2.2 for all the series con rm ing the high uniform ity of the transport properties in the sam ples obtained in the sam e deposition run. Measuring a resistivity value of $_{N b}$ = 2.5 cm in the case of a deliberately fabricated 1000A thick single Nb lm, and assuming a parallel resistorm odel [21], we deduced $_{Pd}$ 5 cm.

IV.RESULTS AND DISCUSSION

In Fig. 1 the critical tem perature T_c is reported as a function of $d_{N,b}$ for the $d_P d/d_N b/d_P d$ trilayers. The transition tem perature of the sam ple with $d_{N,b} = 200$ A is not reported since it was below 1.75 K, the lowest tem perature reachable with our experimental setup. The tem perature asymptotic value of 8.8 K for our bulk N b is reached above 1500 A while, below 450 A, T_c is sensitively reduced. Moreover in Fig. 1 the transition tem peratures $T_c (d_{N,b})$ are compared to those of single N b lm s, clearly indicating that the suppression of the critical tem peratures of the trilayers com es indeed from the proximity e ect rather than from the T_c thickness dependence of single N b. Fig. 2 shows T_c vs d_{Pd}^{in} m easurem ents perform ed on the $d_{Pd}^{out}/d_{N,b}/d_{Pd}^{in}/d_{N,b}/d_{Pd}^{out}$ system s. W ith increasing d_{Pd}^{in} the critical tem perature is lowered

until a non monotonic behaviour with a minimum for d_{Pd}^{in} 140 A is reached, then the curve levels o to a value of 7.8 K for large d_{Pd}^{in} . A similar behavior, consisting in a dip before reaching the maximum and then the asymptotic value, was found in S/F systems such as $V = Fe_x V_{1x}$ [1], $Nb = Pd_{1x} Fe_x = Nb$ [16] and $Nb = Cu_{1x} Ni_x$ [2,22], and may be related to the strong param agnetic nature of Pd, such as the abrupt decrease of T_c for sm all values of d_{Pd}^{in} . A qualitatively explaination for the saturation of the $Tc(d_{Pd}^{in})$ curve can be given by considering that when the Nb layers are separated by a thin Pd layer, the decay of Cooper pairs from both sides overlap, the T_c of the system is increased and we say that the Nb layers are coupled. By increasing d_{Pd}^{in} the Nb layers become more and more decoupled and the critical tem perature reaches a lim iting value related to T_c of the single isolated Nb layer $(d_{Nb} = 500 \text{ A})$. We found that this critical tem perature value is a little higher than the one obtained for the trilayer with $d_{Nb} = 500 \text{ A}$ (T_c 6 K, see Fig. 1). This is probably due to di erent deposition conditions, since these two series were fabricated in di erent deposition runs. Moreover, in the two systems, Nb layers were included in Pd layers of di erent thickness and this may also play a role. The thickness for which the tem perature becomes constant is the decoupling thickness d_{Pd}^{dc} . This thickness is related to the coherence length by $d_{Pd}^{dc} = 2_{Pd}$. We identify d_{Pd}^{dc} extrapolating the steepest slope in the $T_c (d_{Pd}^{in})$ curve to the d_{Pd}^{in} axis (line in Fig. 2) [5]. The value for $_{Pd}$ of approximately 60 A that we nd with this procedure is comparable with other values reported in literature for similar system s [16] while it is considerably lower than the values found for other norm alm etals, such as Cu [5,22], and greater than values found for the ferrom agnetic ones [1,12,14]. In addition this value, in our tem perature range, is in agreem ent with the one estim ated from the measured $_{Pd}$ with the expression of $_{Pd}$ valid in the dirty limit:

$$P_{Pd} = \frac{hD_{Pd}}{2 k_{B}T}$$
(6)

Here D_{Pd} is the di usion coe cient which is related to the low temperature resistivity Pdthrough the electronic mean free path l_{Pd} by [23]

$$D_{Pd} = \frac{V_{Pd} I_{Pd}}{3}$$
(7)

in which

$$l_{pd} = \frac{1}{v_{pd pd pd}} \frac{k_{B}}{e}$$
(8)

where $_{Pd}$ 11:2 10J=K 2 m 3 is the Pd electronic speci c heat coe cient [24] and v $_{Pd}$ = 2.00

 $1\vec{0}$ cm =s is the Pd Ferm i velocity [25]. The values obtained for $_{Pd}$ are between 73 A and 115 A for T = 10 K and T = 4 K, respectively, while, from Eq. (8), $\frac{1}{Pd} = 60$ A. The value of the ratio $\frac{1}{Pd} = _{Pd}$, always less than one in the considered temperature range, con rm s the validity of the dirty lim it approximation.

Inspired by these results we also tried to explain the abrupt decrease and the dip of T_c shown in Figure 2 extending the Radovic theory [26] to the case of S/N systems with N a norm almetal with high spin susceptibility. W hile Radovic's theory well describes this behaviour for both S/F [14,15] and S/M systems [27], we did not obtain a good agreement with the experimental data. However we have to remark that for Nb/Pd multilayers a monotonic decrease of T_c (d_{Pd}) was observed [10,16,28]. This behaviour has been discussed in the framework of de Gennes-W ertham er theory, but at the price of supposing very low or, alternatively, very high values of Pd resistivities [10,28].

Upper critical elds of $d_{Pd}/d_{Nb}/d_{Pd}$ trilayers were also measured in order to determine (0), the G inzburg-Landau coherence length at zero temperature, from the slope $S = dH_{C2}=dT_{J=T_c}$. Nb is, in fact, related to (0) by the relation Nb=2 (0)/. The slope S is extrapolated from the $H_{C2?}$ (T) curves by a linear t near T_c , as shown in Fig. 3. A value of about Nb= 64 A was found for single Nb lm, 1000 A thick and this value agrees with the one obtained for sam ples with thicker Nb interlayers (d_{Nb} 700A). It is also interesting to note that $H_{C2?}$ (T) slopes for the di erent sam ples are quite constant, which is a behaviour already observed in S/F system s [14]. In Fig. 4 parallel critical magnetic elds are shown. The main feature of these curves is the square root behaviour of H_{C2k} (T) in all the tem perature range and the absence of the 3D 2D crossover. A lso this feature m ay be related to the magnetic nature of Pd. So, from both perpendicular and parallel critical elds m easurem ents seem s to emerge that Nb/Pd system s behave m ore as a S/F rather than a

S/N system, even if this indication is not con rm ed by T_c 's measurements. A similar behaviour was alrealy observed in Nb/Pd multilayers [10]. In this case the critical temperature showed a monotonic decrease as a function of the Pd thickness, which was described in the framework of the classical G ennes-W ertham er proximity theory valid for S/N systems. On the other hand the hypothesis of the Pd ferrom agnetic nature seem ed to be the reason of the early 3D 2D dimensional crossover observed in H_{C2k} (T) measurements [10].

W ith these results for $_{
m N\,b}$ and $_{
m P\,d}$ and with the measured $_{
m N\,b}$ and $_{
m P\,d}$ values reported above it is possible to calculate the proximity e ect parameter = 0.53 and to reproduce T_{c} (d_{N b}) of the trilayers by Eq. (3) with only one free parameter, b. As reported above in Eq. (3), the validity regime of the W ertham er approximation is $T_c=T_{cs}$ = b. In our case, even if the condition is not fully satised, the ratio = $_{\rm b}$ = 0:4 is always less than $T_{\rm c}=T_{\rm cs}$. In fact $T_c=T_{cs}$, in the trilayers critical tem peratures range, is between 0.5 1. The result of the calculation is shown in Fig. 1 (solid line) and it is obtained for $_{\rm b}$ =1.17, which means T = 0.46. In Fig. 1 are also shown the curves obtained for di erent T values (T = 0.42, 0.46, 0.54 from left to right). It is evident that varying T only of 0.04 the accordance between the theory and the experim ental data is completely lost. In addition, motivated by the observed $H_{C2?}$ (T) and H_{C2k} (T) behaviours, we tried to reproduce the experimental results with the extended theory for S=F system s [1]. However in this case the best t to the data is obtained for T = 0.86, which seem s to be an unphysical value for the transparency of a real system . Of course if we also identify $p_d = q_d^{dc}$, as recently reported [29,30], the interface transparency will be further increased. In particular we are not able to reproduce the experimental point even if we use T = 0.99. From the curve in Fig. 1 it is possible to determ ine the value of $d_{N b}^{cr}$ 200A. In Table I are sum marized all the sam ples parameters. The critical thickness normalized to the coherence length in Nb can also be calculated. It depends both on interface transparency and on the strength of the pairing, low ering with increasing $_{Pd}$ and decreasing T. In S/F systems with T = 1, d_s^{cr}/s has its theoretical upper limit close to 6 [1]. The value we obtained, $d_{Nb}^{cr}/_{Nb}$ 3, is comparable to that $(d_{Nb}^{cr}/_{Nb} = 2.69)$ reported for N b=C $u_{0.915}$ M $n_{0.085}$ system s having T = 0.33 [5] and sensitively higher than the

one found for Nb/Cu ($d_{Nb}^{cr}/_{Nb} = 0.48$) with T = 0.29 [5]. The ratio is lower than ours also for Nb=Cu_{1 x} N i_x, probably due to the little interface transparency of those system s [2,22]. The obtained T value for Nb/Pd systems is substantially high, although lower than expected on theoretical argument based on Ferm i velocities m ism atch. The values v_s $v_{Nb} = 2.73$

 10° cm =s β 1] and v_{n} 10° cm =s [25] in Eq. (1), in fact, would yield ¥_d=2.00 T = 0.98. This happens also for other S/N system s, such as N b/C u, where T_{exp} 0:29 0:33 [5,22], while T = 0.8 should be expected, for Nb/Alwith T_{exp} 0.2-0.25 [5,32] instead of T = 0.8, and for Ta/Alwith T_{exp} 0.25 [5]. Another very important factor to have a high T value is the matching between band-structures of the two metals. This parameter in uences transparency even more than Ferm i velocities. Conduction electrons in Nb and Pd have both a strong d-character [5,25,11] and this fact would also lead to high values of T. Anyway, as we said, also lattice m ism atches play a role. In Nb/Pd system s the growth of the booth structure on the footh one may induce stress at the interfaces. High values of the interface roughness reported in literature for sim ilar N b/P d system s fabricated with di erent deposition techniques [10,16,28] are consistent with these considerations. In this sense a system atic study of the in uence of the fabrication method on interface transparency, as already done on Nb/Cu system s [4], would be interesting. Since preparations methods seem to have a strong in uence on T, we could expect to have samples of higher quality, and consequently, of larger transparency using, for example, Molecular Beam Epitaxy (MBE) deposition technique.

V.CONCLUSIONS

In conclusion we have studied the proximity e ect in Nb/Pd layered systems using the interface transparency as the only free parameter. We obtained a relatively high value for T, higher than the one found for Nb/Cu, in accordance with theoretical considerations about m ism atches between Ferm i velocities and band-structures of the two metals. A nyway the value obtained for T can only be indicative: it depends on several factors, such as the

way we extracted $_{P\,d}$ from the T_{c} ($d_{P\,d}^{in}$) curves neglecting its tem perature dependence, the measured values of $_{\rm N\,b}$ and $_{\rm P\,d}$ and the approximation used to go from $_{\rm b}$ to T . W hat emerges from this study is that Nb/Pd is, in a sense, an intermediate system between the well known Nb/Cu and other S/F or S/M systems such as Nb/Fe, V/Fe, Nb=Cu_{1 x} Ni_x or Nb/CuMn. The high values of the ratio $d_{Nb}^{cr} = Nb$ and the lack of agreement between R adovic's theory and experimental results can be explained by good interface transparency rather than by magnetic arguments. In this sense it is useful to compare our result with the one obtained for Nb/CuMn. The ratio d_s^{cr}/s is comparable for the two systems [13]. On the other hand the stronger magnetic nature of CuMn is known and also indirectly dem onstrated by Radovic's t, that well describes the critical tem perature behavior for Nb/CuM n multilayers [27] but not for Nb/Pd. Thism akes us think that Pd-based m agnetic alloys are good candidates for studying the S/F proximity problem : very low impurity concentrations will induce ferrom agnetic ordering, but should not produce great disorder at the interface. An interesting alloy could be P dN i: the magnetic order starts to appear for a Niconcentration of 2.5 %. This makes the alloy stoichiom etry easy to control and induces an hom ogeneous ferrom agnetism, with a relatively low Curie tem perature [33,34]. In this sense PdN issem s to be m ore intriguing than CuN ibecause of the low values of the interface transparency measured in Nb/CuNisystems.

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TABLES

TABLE I. Values of the electrical resistivities $_{N\,b}$ and $_{P\,d}$, of the coherence lengths $_{N\,b}$ and $_{P\,d}$ as experimentally determined and used in the tprocedure to estimate the ratio $d_{N\,b}^{rr}/_{N\,b}$, and the transparency parameter T.

_{Nb} (cm)	_{Pd} (cm)	_{Nb} (A)	_{Pd} (A)	$d_{\rm N~b}^{\rm cr}/$ $_{\rm N~b}$	Т
2.5	5.0	64	60	32	0.46

FIGURES

FIG.1. Critical tem perature T_c versus N b thickness $d_{N b}$ for $d_{P d}/d_{N b}/d_{P d}$ trilayers (solid sym – bols). Dierent sym bols refer to sam ple sets obtained in dierent deposition runs (set A and set B). Open sym bols refer to single N b in s. The dashed line shows the T_c of our bulk N b. The solid line is the result of the calculations with the parameters given in Table I. The arrow indicates the value of $d_{N b}^{cr}$. The dashed and the dot-dashed lines indicate the theoretical calculation for T = 0.42 and T = 0.54, respectively.

FIG.2. Critical temperature T_c versus inner Pd thickness d_{Pd}^{in} for sample set C. The arrow shows the value of d_{Pd}^{dc} . The line indicates the method used to determ inate it.

FIG.3. Perpendicular critical magnetic eld for $\frac{1}{d_N} \frac{1}{d_N} \frac{1}{d_P} \frac{1}{d_$

FIG.4. Parallel critical magnetic eld for the sam e $\frac{1}{2} \frac{d}{d_N b} \frac{d_P d}{d_P d}$ trilayers with di erent $\frac{1}{2} \frac{d_N b}{d_P d}$ as in Fig. 3.







